

Notice of References Cited	Application/Control No. 10/780,256	Applicant(s)/Patent Under Reexamination O'BANION ET AL	
	Examiner Katherine W. Mitchell	Art Unit 3677	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-549,555	11-1895	White	411/456
	B	US-4,167,885	09-1979	Paskert et al.	411/478
	C	US-3,121,366	02-1964	ADOLF PANZER	411/456
	D	US-727,111	05-1903	Duffy	411/451.3
	E	US-D481,622	11-2003	Whipple et al.	D8/388
	F	US-52,773	02-1866	Perovich	416/52
	G	US-4,796,848	01-1989	Lanz, Donald D.	248/71
	H	US-6,139,238	10-2000	Anstett, David A.	411/451.1
	I	US-2,649,831	08-1953	ANSTETT EDGAR P	411/80.1
	J	US-3,499,359	03-1970	YRJANAINEN JOHN J	411/451.3
	K	US-D481,621	11-2003	Whipple et al.	D8/388
	L	US-D497,101	10-2004	Whipple et al.	D8/388
	M	US-D481,302	10-2003	Whipple et al.	D8/388

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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